APPROVAL SHEET



CUSTOMER:	
DESCRIPTION:	DT38 32.768KHz Quartz Crystal Resonator
MANUFACTURER PART NO.:	FTX32.768K12.5D8-20PPM
CUSTOMER PART NO:	
USED IN MODEL:	
REVISION	A1

	承	认	A	PPROVAL
工程部	듄	质部		采购部
TECHNOLOGY DEPT.	QUAL	JTY DEPT.		PURCHASING DEPT.

Date: September 18, 2017

Rev	Revise page	Revise contents	<u>Date</u>	Ref.No.	Reviser
A1	ALL	Initial released		N/A	DavidJiang

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1. QUARTZ CRYSTAL UNIT SPECIFICATION

1.1 Frequency: 32.768KHz

1.2 Holder type: DT38

1.3 Frequency tolerance: ±20ppm at 25℃

1.4 Equivalent resistance: 30Kohms Max

1.5 Operating temperature range: -10°C To +60°C

1.6 Storage temperature range: -40°C To +85°C

1.7 Temperature Coefficient: $-0.04 \times 10^{-6} / ^{\circ} \text{C}^2 \text{ max}$

1.8 Loading capacitance (CL): 12.5pF

1.9 Drive level: 1.0uW max

1.10 Shunt Capacitance: 2.0pF Typical

1.11 Motional Capacitance:

1.12 Insulation resistance: More than 500M ohms

1.13 Aging: Less than ±3 ppm/Year

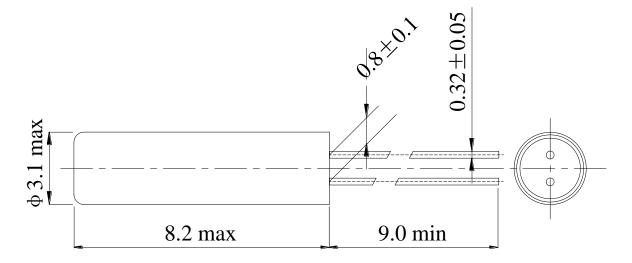
Ta=+25°C±3°C, first year

1.14 Dimensions and marking: Refer to page.3

1.15 Emboss carrier tape & reel: Refer to page.4

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2. DIMENSIONS (Unit: mm)



Note:

The soldering position has to be at the lead wire more than 1.0mm away from the glass seal. When mounting or removing a quartz crystal unit, heat the lead part at 300°C or lower for 5 seconds or less. A long period of time of heating may result in deterioration of the characteristics and may break the crystal unit. Be sure not to heat the case by flow soldering and so on.

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3. Mechanical Endurance: Provided that measurement shall be carried out afterletting it alone in the room temperature for 1 hour.

Test Item	Condition of Test	Performance Requirements
Shock (Destructive)	Resonator shall be tested after 3 times random drops from the height of 75 cm onto hard wooden broad of thickness more than 30 mm.	No visible damage, measured Values shall meet Table 1.
Vibration (Destructive)	Subject resonator to following vibration Frequency: 10-55Hz Amplitude: 0.75mm Cycle time: 1~2min(10-55-10Hz) Duration: 3 mutually perpendicular Planes in each 2 hours Direction: X, Y, Z	No visible damage, and measured Values shall meet Table 1.
	Pulling: body of resonator shall be fixed, and 0.5kg of tension weight shall be supplied gradually to axial direction of lead terminals for 30 seconds	The lead shall not b
Terminal Strength (Destructive)	Bending: body of resonator shall be fixed, And 90°Cbending at a distance of 2.5±0.5 mm from crystal main body shall be given being supplied 250g tension weight. after that, lead terminals shall be straightened gradually. Then, the same bending and straightening shall be supplied to the opposite direction in the same axial.	measured Values shall
Solder Heating (Destructive)	Each lead terminals shall be dipped into the solder melted tank at 300±10°C for 3±0.5 resonator ,and at 260±10°C for 10 ± 1 seconds by the same way.	No visible damage, and measured Values shall meet Table 1.
Solder DIP. (Destructive)	Dip the lead in liquid solder for 2± 0.5 seconds, at 230±5°C and 6.0mm from the root, after this dipping, 90% min. of dipped parts shall be covered with solder.	No visible damage, and measured Values shall meet Table 1.
Leakage (non-destructive)	The resonator is to be soaked in the alcohol and enforced with the pressure of 25N/cm² for 5 minutes Next, the resonator shall be tested after being taken out and dried with a dryer.	The Ir between the wire and the shell must be more than $500M\Omega$.

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4. Environmental Endurance: Provided that measurement shall be carried out afterletting it alone in the room temperature for 1 hour.

	Item	Conditions	Specifications
4.1	Humidity	Should be satisfied after letting it alone at +60°C±2°C in humidity of 85% ± 5% for 240 hours.	No visible damage, measured Values shall meet Table1.
4.2	Storage in Low Temperature	Should be satisfied after letting it alone at -30°C±2°for 240 hours.	No visible damage, measured Values shall meet Table1
4.3	Storage in High Temperature	Should be satisfied after letting it alone at +85°C±2°C for 240 hours.	No visible damage, measured Values shall meet Table1
4.4	Temperature Cycle	Should be satisfied after supplying the following temperature cycle (10 cycles). (Refer to Fig-4). Temperature shift from low to high, high to low shall be done in 1°C/min.	No visible damage, measured Values shall meet Table1

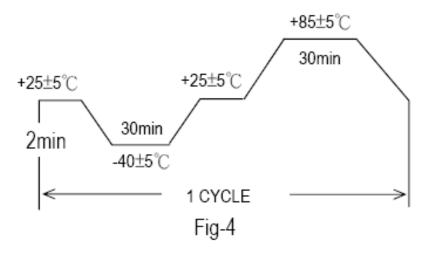


Table 1

Test Item	Specification	Note
Frequency change (△f/fo)	5ppm	Reference to the initial value

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C.I. (R)		15%	Reference to the initial value	
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